**Sensors, Signals and Noise** 

# COURSE OUTLINE

- Introduction
- Signals and Noise
- Filtering
- Sensors: PD4 PhotoMultiplier Tubes PMT

#### **Photo Multiplier Tubes (PMT)**

- Photodetectors that overcome the circuit noise
- Secondary Electron Emission in Vacuum and Current Amplification by a Dynode Chain
- Photo Multiplier Tubes (PMT): basic device structure and current gain
- Statistical nature of the current multiplier and related effects
- Dynamic response of PMTs
- Signal-to-Noise Ratio and Minimum Measurable Signal

**Circuit Noise limits the sensitivity of photodiodes ...** 



Detector Signal (current at photocathode and anode): just one electron per detected photon! 3



- Primary Signal (photocathode current): one electron per detected photon
- Output (anode) current: **G** >10<sup>3</sup> electrons per primary electron
- Dark-current noise and/or photocurrent noise at detector output are much higher than circuit noise, which has practically negligible effect

# Secondary Electron Emission in Vacuum and Current Amplification by a Dynode Chain

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### **Secondary Electron Emission in Vacuum**



- A primary electron is emitted in vacuum with very little kinetic energy
- Driven in vacuum by a high potential difference (some 100V), it impacts with high energy on a **dynode** (electrode coated with suitable material, see later)
- Energy is transferred to electrons in the dynode; some of them gain sufficient energy to be emitted in vacuum; g > 1 is the yield of secondary electrons per primary electron

#### **Dynode materials**



Secondary emitter coatings with ordinary yield:

- MgO Magnesium Oxide
- Cs<sub>3</sub>Sb Cesium Antimonide
- BeO Beryllium Oxide
- Cu-Be Copper-Beryllium alloys

Secondary emitter with high yield:

• GaP Gallium Phosphide

- In the normal working range up to ≈500V, the emission yield g is proportional to the accelerating voltage V (i.e. the primary electron energy) g = k<sub>s</sub>V<sub>D</sub>
- At higher voltage g rises slower and tends to saturate (energy is transferred also to electrons in deeper layers, which have lower probability of escape in vacuum)
- In the linear range ordinary emitters work with *g* values from ≈1,5 to ≈7 and GaP dynodes *g* values from ≈5 to ≈25
- GaP dynodes are more costly and delicate, require special care in operation and their yield tends to decrease progressively over long operation times

### **Electron Multiplier**

## Sketch of the Principle (example with 5 dynodes)



- $V_{\rm K} < V_{\rm D1} < V_{\rm D2} < V_{\rm D3} < V_{\rm D5} < V_{\rm A}$
- Electron optics (i.e. potential distribution) carefully designed to lead the electrons emitted from each electrode to the next one
- $\rightarrow$   $g_r > 1$  secondary electron yield of dynode r
- $\succ G = g_1 \cdot g_2 \cdot g_3 \cdot g_4 \cdot g_5 \text{ overall multiplier gain}$

that is,  $G=g^5$  with equal stages  $g_1=g_2=...=g$ 

# Photo Multiplier Tubes (PMT): device structure and current gain

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#### **Side-on PhotoMultiplier Tubes PMTs**



PMTs with side-window and opaque photocathode

The basic structure of Photomultiplier Tubes with discrete dynodes and electrostatic-focusing was first demonstrated in 1937 by the RCA Laboratories; in the following decades it was progressively improved and developed by various industrial laboratories (RCA, DuMont, EMI, Philips, Hamamatsu...)

#### **End-on PhotoMultiplier Tubes PMT**

PMTs with end-window and semitransparent photocathode



PMT Operation sketch



#### **PMTs with semitransparent photocathode**



# **PMT Gain Regulation and Stabilization**

• PMTs can have high number *n* of dynodes (from 8 to 12) and attain high gain G.

With n equal dynodes it is  $G = g^n$ ; e.g. with 12 dynodes  $G=g^{12}$ 

G =  $10^4$  with g = 2,2 G =  $10^5$  with g = 2,6 G =  $10^6$  with g = 3,2

- G is controlled by the dynode bias voltage, which regulates the dynode yield g
- A single supply is usually employed, with high voltage V<sub>A</sub> typically from 1500 to 3000 V. The dynode voltages are obtained with a voltage-divider resistor chain; the potential difference V<sub>i</sub> between two dynodes j and (j-1) is a preset fraction f<sub>i</sub> of the supply V<sub>A</sub>

## **PMT Gain Regulation and Stabilization**

• The supply voltage V<sub>A</sub> thus rules the yield  $g_j$  of every dynode  $g_j = k_S V_j = k_S f_j V_A$ and the total gain  $G = g_1 g_2 \dots g_n = k_S V_1 \cdot k_S V_2 \dots k_S V_n = k_S^n f_1 f_2 \dots f_n \cdot V_A^n$ which increases with V<sub>A</sub> **much more** than linearly

$$G = k_S^n f_1 f_2 \dots f_n \cdot V_A^n = K_G \cdot V_A^n$$

(NB:  $K_G = k_S^n f_1 f_2 \dots f_n$  is constant, set by the voltage distribution and dynode characteristics)

• The gain G is very sensitive to even small variations of the supply  $V_A$ : the relative variations of supply voltage are n-fold amplified in the relative variations of gain

$$\frac{dG}{G} = n\frac{dV_A}{V_A}$$

Consequently, tight requirements must be set to the stability of the high voltage V<sub>A</sub> versus ambient temperature and/or power-line voltage variations.
e.g. getting *G* stability better than 1% for a PMT with n=12 dynodes requires a high voltage supply V<sub>A</sub> better stable than 0,08 %

# **Cautions and limits in PMT exploitation**

- For limiting self-heating of voltage divider below a few Watt, the divider current must be < 1 mA, hence total divider resistance must be at least a few MΩ.</li>
- In order to avoid nonlinearity in the current amplification, variations of dynode voltages caused by the PMT current should be negligible. The PMT output current must thus be less than 1% of the divider current, i.e. typically a few μA.
- This limit is acceptable for DC current, but not for pulsed optical signals. However, fast transients of dynode voltages can be limited by introducing in the last stages capacitors in low-pass filtering configurations, as sketched in the examples

$$k \qquad d_1 \quad d_2 \quad d_3 \quad d_4 \quad d_5 \quad d_6 \quad d_7 \quad d_8 \quad d_9 \qquad A_1 \qquad A_2 \qquad A_3 \qquad A_4 \qquad A_5 \qquad A_6 \qquad A_7 \quad A_8 \quad A_9 \qquad A_7 \qquad A_8 \qquad A_9 \qquad A_8 \qquad A_9 \qquad A_8 \qquad A_9 \qquad A_8 \qquad A_9 \qquad A_9 \qquad A_8 \qquad A_9 \qquad$$

## **Cautions and limits in PMT exploitation**



- **Space-charge effects may cause nonlinearities** in the amplification of fast pulsed signals. A high charge of the signal itself can significantly reduce the electric field that drives the electrons: the higher is the pulse, the slower gets the electron collection.
- Nonlinearity can occur also if the voltage signal developed on the load is high enough to reduce the driving field from last dynode to anode
- Magnetic fields have very detrimental effect: the electrons traveling in vacuum are deviated and the operation is inhibited or badly degraded. With moderate field intensity, magnetic screens can limit the effects; with high intensity fields PMT operation is actually impossible
- PMTs are fairly delicate and subject to fatigue effects and their operation is prejudiced by mechanical vibrations

# Statistical nature of the electron multiplier and related effects

# **Single Electron Response SER**

- The PMT output is superposition of elementary current pulses that correspond to single electrons emitted by the cathode, called **Single Electron Response (SER)** pulses.
- SER current pulses are fast (a few nanosecond width) and fairly high (pulse-charge Gq from 10<sup>5</sup> to 10<sup>6</sup> electrons). They are remarkably higher than the noise of fast circuits; with PMT weakly illuminated they are well observable on the oscilloscope screen and each of them corresponds to the detection of a single photon.
- The SER current pulses observed have all equal pulse shape, but **randomly varying pulse-amplitude**; i.e. G is not constant, but statistical



- The random fluctuations of G are due to the statistical nature of secondary electron emission
- Since the SER charge is much higher than the minimum measurable detector pulse, the statistical distribution p(G) of the gain G can be directly collected by measuring and classifying the pulsecharge of many SER pulses.

#### Statistical Distribution of the PMT gain



- The plot above sketches the typical appearance of the statistical distribution p(G) of the PMT gain G.
- For different PMT models and different operating conditions (bias voltage distribution on dynodes; temperature of operation; etc.) remarkably different *p(G)* are observed. The distributions are roughly akin to gaussian, but skewed toward high *G* values.
- The main parameters to be considered for analyzing the PMT operation are mean gain  $\bar{G}$ , gain variance  $\sigma_{\rm G}^2$  and relative variance  $v_{G}^2 = \frac{\sigma_{G}^2}{(\bar{G})^2}$

# **Excess Noise due to Gain Fluctuations**

- Emission of primary electrons from cathode is a process with Poisson statistics, i.e. mean number  $N_p$ , variance  $\sigma_p^2 = N_p$  and relative variance  $v_p^2 = \frac{\sigma_p^2}{N_p^2} = \frac{1}{N_p}$
- Emission is followed in cascade by statistical multiplication with fluctuating G
- The mean of the cascade output is  $N_u = N_p \cdot \bar{G}$  (two independent processes)
- The Laplace theory of probability generating functions shows that the relative variance  $v_u^2$  of the output of a cascade is sum of the relative variance of every stage in the cascade divided by the mean value of all the previous stages. In our case:

$$v_u^2 = \frac{\sigma_u^2}{N_u^2} = v_p^2 + \frac{v_g^2}{N_p} = \frac{1}{N_p} + \frac{v_g^2}{N_p} = \frac{1}{N_p} (1 + v_g^2)$$

• The variance  $\sigma_u^2$  thus is

$$\sigma_u^2 = N_p^2 \overline{G}^2 v_u^2 = N_p \overline{G}^2 (1 + v_G^2) = \sigma_p^2 \ \overline{G}^2 (1 + v_G^2)$$

In conclusion, the PMT :

1) amplifies the input variance by the square gain  $\overline{G}^2$ , like an amplifier and

2) further enhances it by the Excess Noise Factor F due to the gain fluctuations

$$\sigma_u^2 = \sigma_p^2 \cdot \overline{G}^2 \cdot F$$
 with  $F = 1 + v_G^2 > 1$ 

 $F \leq 2$  for most PMT types and F is close to unity for high quality PMT types.

# **Dynamic response of PMTs**

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#### **PMT Dynamic Response: SER pulse**

PMT response to a single photon



# **PMT Dynamic Response: SER pulses**

 Differently from vacuum tube photodiodes, in PMT the rise of a SER current pulse is delayed (from ≈10ns to some 10ns dependent on PMT type and bias voltage) with respect to the photon arrival. The dynodes electrostatically screen the anode, so that only electrons traveling from last dynode to anode induce current (Shockley-Ramo theorem).

The **PMT transit time** *t<sub>b</sub>* is defined as the delay of the **pulse barycenter**.

- The transit time  $t_b$  randomly fluctuates from pulse to pulse, with a transit time jitter  $T_j$  (full-width at half maximum FWHM of the  $t_b$  distribution) from a few 100ps to a few ns depending on PMT type and bias voltage.  $T_j$  is due to the statistical dispersion of the electron trajectories in the *first stages of the multiplier*.
- The SER pulse width  $T_w$  (FWHM from a few ns to various ns, depending on PMT type and bias voltage) is always wider than the transit time jitter:  $T_w \approx 5$  to 10 times  $T_j$ . It is due to the statistical dispersion of the electron trajectories *in all the multiplier*.
- $T_w$  has very small fluctuations, practically negligible

# Signal-to-Noise Ratio and Minimum Measurable Signal

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# Noise sources and filtering with PMTs



- $n_p$  photoelectron rate  $\rightarrow I_p = n_p q$  photocurrent
- $n_D$  dark electron rate  $\rightarrow I_D = n_D q$  cathode dark current
- $n_b$  electron rate due to photon background  $\rightarrow I_b = n_b q$  photon background current
- $n_B = n_D + n_b$  total background electron rate  $\rightarrow I_B = n_B q$  total background current Noise sources :
- > at cathode:  $S_{ip}=2qI_p=2q^2n_p$  photocurrent noise, increases with the signal
- > at cathode:  $S_{iB}=2qI_B=2q^2n_B$  background noise, **independent from the signal**
- $\succ$  at anode: resistor load noise  $S_{iR}$  and preamplifier noise  $S_{iA}$  and  $S_{iR}$

Let's deal with S/N and minimum measurable signal in the basic case: constant signal current  $I_p$  and low-pass filtering (typically by Gated Integration)

## Noise sources and filtering with PMTs



We consider cases with wide-band load, i.e. with  $1/4R_LC_L >> f_F$ , such that

- a) the filtering effect of  $C_L$  is negligible
- b) the circuit noise can modeled simply by a current generator

$$S_{ie} = S_{iA} + S_{iR} + \frac{S_{\nu A}}{R_L^2}$$

which can be referred back to the input (at the photocathode) as  $S_{ie}/G^2F$ 





- The circuit noise  $S_{ie}$  can be modeled by a shot current **at the anode**:  $I_e = S_{ie}/2q$  with electron rate  $n_e = I_e/q = S_{ie}/2q^2$
- With wide band preamplifier and low resistance  $R_L \approx \text{few } k\Omega$  the circuit noise typically is  $\sqrt{S_{ie}} \approx 2 pA/\sqrt{Hz}$  or more. The equivalent shot electron rate is  $n_e \approx 10^{14}$  el/s or more
- Referred to input (cathode), the circuit noise is modeled by a shot current with **reduced** electron rate  $n_e/FG^2$ . For instance, with G= 10<sup>6</sup> it is  $n_e/FG^2 \approx 100 \text{ el/s}$
- The circuit noise referred to the input added to the background noise  $S_{iB}=2qI_B=2q^2n_B$ gives the **constant** noise component (i.e. **NOT** dependent on the signal)

$$S_{iB} + \frac{S_{ie}}{G^2 F} = 2qI_B + \frac{2qI_e}{G^2 F} = 2q^2 \left(n_B + \frac{n_e}{G^2 F}\right)$$

# **Role of the Circuit Noise**



- The role of the circuit noise is assessed by comparing it to the constant noise source of the PMT, the background noise  $S_{iB}=2qI_B=2q^2n_B$
- The background electron rate at the cathode n<sub>B</sub> may vary *from a few el/s to a few* 10<sup>6</sup> el/s, depending on the photocathode type and operating temperature and on the background light level (see Slides PD2)
- In most cases of PMT application it is  $n_B >> n_e/G^2F$ : the equivalent electron rate  $n_e/G^2F$  is totally negligible with respect to  $n_B$ , the circuit noise plays no role
- In cases with moderate gain G and/or very low dark current the circuit noise contribution may be significant and is very simply taken into account, by employing the resulting density of constant noise component in the evaluation

#### **Minimum Measurable Signal**

For the sake of simplicity in the following computations we consider:

- a) negligible circuit noise. Anyway, we know when it must be taken into account and how to do it, by considering an increased constant component of noise.
- **b)** negligible excess noise, i.e. F = 1. Anyway, cases with non-negligible F > 1 can be taken into account simply by introducing the factor  $\sqrt{F}$  to decrease the S/N and increase the noise variance and the minimum signal computed with F=1.



The minimum signal  $I_{p,min}$  is reached when S/N = 1: we will see that the result markedly depends on the **relative size of constant noise vs photocurrent noise** 

# Minimum Signal limited by Photocurrent-Noise

• The simplest extreme case is with negligible background noise: only photocurrent noise matters. With noise band-limit  $f_F = 1/2T_F$  (GI filtering)

$$\frac{S}{N} = \frac{I_p}{\sqrt{2qI_pf_F}} = \frac{I_pT_F}{\sqrt{qI_pT_F}} = \sqrt{\frac{I_pT_F}{q}} = \sqrt{n_pT_F} = \sqrt{N_p}$$

- $N_p = n_p T_F$  is the **number of photoelectrons** in the filtering time  $T_F$ .
- In fact, the S/N can be obtained directly from the Poisson statistics of photoelectrons: with mean number  $N_p$ , the variance is  $\sigma_p^2 = N_p$  and

$$\frac{S}{N} = \frac{N_p}{\sigma_p} = \frac{N_p}{\sqrt{N_p}} = \sqrt{N_p}$$

• Remark that in this case the noise is **NOT constant,** independent from the signal: as the signal goes down, **also the noise goes down!!** 

# **Minimum Signal limited by Photocurrent-Noise**

• By making lower and lower  $I_p$ , when S/N = 1 the minimum signal  $I_{p,min-p}$  is reached

$$\left(\frac{S}{N}\right)_{min} = 1 = \sqrt{\frac{I_{p,\min-p}T_F}{q}} = \sqrt{n_{p,\min-p} T_F} \sqrt{N_{p,\min-p}}$$

• The minimum measurable photocurrent signal  $I_{p,min-p}$  corresponds to just **one photoelectron in T\_F**, the filter weighting time:

$$I_{p,\min -p} = \frac{q}{T_F} \qquad \qquad n_{p,\min -p} = \frac{1}{T_F} \qquad \qquad \boxed{N_{p,\min -p} = 1}$$

• Observing the complete S/N equation

$$\frac{S}{N} = \frac{I_p}{\sqrt{2qI_pf_F + 2qI_Bf_F}} = \frac{I_pT_F}{\sqrt{qI_pT_F + qI_BT_F}} = \frac{n_pT_F}{\sqrt{n_pT_F + n_BT_F}} = \frac{N_p}{\sqrt{N_p + N_B}}$$

we see that the background noise is truly negligible only if  $I_B << I_p$  for any  $I_p$  **down** to the minimum  $I_{p, min-p}$ , i.e. only if



# Minimum Signal limited by Photocurrent-Noise



Signal measured by charge, in terms of number of photoelectrons  $N_p = n_p T_F$ 

# Minimum Signal limited by Background Noise

• The opposite extreme case is with negligible photocurrent noise: only background noise matters. More precisely, it's the case where the limit current  $I_p = I_{p,min-p}$  computed with only the photocurrent noise is much lower than the background current  $I_B$ 

$$\boxed{I_B \gg \frac{q}{T_F}} \qquad \qquad \boxed{n_B \gg \frac{1}{T_F}} \qquad \qquad \boxed{N_B \gg 1}$$

• There is now a different **minimum signal** *I*<sub>*p*,min-B **limited by the background noise**</sub>

• In **intermediate cases both noise components** contribute to limit the minimum signal, which is computed from

$$\frac{S}{N} = \frac{N_{p,\min}}{\sqrt{NB_{p,\min}}} = 1 \qquad 2^{nd} \text{ order equation that leads to} \qquad N_{p,\min} = \frac{1}{2} \left(1 + \sqrt{1 + 4N_B}\right)$$

#### **Minimum Signal limited by Noise**



Signal charge, in terms of number of photoelectrons  $N_p = n_p T_F$ 

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